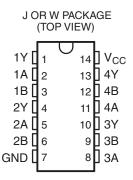
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# RAD-TOLERANT CLASS V, QUADRUPLE 2-INPUT POSITIVE-NOR GATES

## **FEATURES**

- AC Types Feature 1.5-V to 5.5-V Operation
- Rad-Tolerant: 50 KRad(Si) TID (1)
  - TID Dose Rate < 2 mRad/sec
- QML-V Qualified, SMD 5962-87612

 Radiation tolerance is a typical value based upon initial device qualification. Radiation Lot Acceptance Testing is available contact factory for details.



# **DESCRIPTION**

The <u>'AC02</u> devices contain four independent 2-input NOR gates that perform the Boolean function  $Y = \overline{A} \cdot \overline{B}$  or  $Y = \overline{A} + \overline{B}$  in positive logic.

# ORDERING INFORMATION(1)

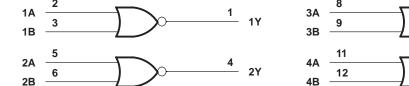
T <sub>A</sub>	PACK	ORDERABLE PART NUMBER	TOP-SIDE MARKING	
–55°C to 125°C	J - package	tubo	5962-8761203VCA	5962-8761203VCA
-95 C to 125 C	W - package	tube	5962-8761203VDA	5962-8761203VDA

- (1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI Web site at www.ti.com.
- (2) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

# FUNCTION TABLE (EACH GATE)

INP	UTS	OUTPUT
Α	В	Y
Н	Χ	L
Х	Н	L
L	L	Н

# **LOGIC DIAGRAM (POSITIVE LOGIC)**





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# ABSOLUTE MAXIMUM RATINGS(1)

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
$V_{CC}$	Supply voltage range		-0.5	6	V
I <sub>IK</sub>	Input clamp current <sup>(2)</sup>	$V_I < 0$ or $V_I > V_{CC}$		±20	mA
I <sub>OK</sub>	Output clamp current <sup>(2)</sup>	V <sub>O</sub> < 0		±50	mA
Io	Continuous output current	$V_O = 0$ to $V_{CC}$		±50	mA
	Continuous current through V <sub>CC</sub> or GND			±100	mA
T <sub>stg</sub>	Storage temperature range		-65	150	= C

<sup>(1)</sup> Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

# **RECOMMENDED OPERATING CONDITIONS<sup>(1)</sup>**

			T <sub>A</sub> = 2	T <sub>A</sub> = 25°C		TO ℃	UNIT
			MIN	MAX	MIN	MAX	
$V_{CC}$	Supply voltage		1.5	5.5	1.5	5.5	V
		V <sub>CC</sub> = 1.5 V	1.2		1.2		
$V_{IH}$	High-level input voltage	$V_{CC} = 3 V$	2.1		2.1		V
		V <sub>CC</sub> = 5.5 V	3.85		3.85		
		V <sub>CC</sub> = 1.5 V		0.3		0.3	
$V_{IL}$	Low-level input voltage	$V_{CC} = 3 V$		0.9		0.9	V
		$V_{CC} = 5.5 \text{ V}$		1.65		1.65	
VI	Input voltage		0	$V_{CC}$	0	$V_{CC}$	V
Vo	Output voltage		0	$V_{CC}$	0	$V_{CC}$	V
I <sub>OH</sub>	High-level output current	V <sub>CC</sub> = 4.5 V to 5.5 V		-24		-24	mA
I <sub>OL</sub>	Low-level output current	V <sub>CC</sub> = 4.5 V to 5.5 V		24		24	mA
Δt/Δν	Input transition rice or fall rate	V <sub>CC</sub> = 1.5 V to 3 V		50		50	ns/V
ΔΙ/ΔΙ	Input transition rise or fall rate	V <sub>CC</sub> = 3.6 V to 5.5 V		20		20	115/ V

All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

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<sup>(2)</sup> The input and output voltage ratings may be exceeded provided the input and output current ratings are observed.



# **ELECTRICAL CHARACTERISTICS**

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST	CONDITIONS	V <sub>cc</sub>	T <sub>A</sub> = 2	:5°C	–55°C TO 125°C		UNIT
				MIN	MAX	MIN	MAX	
			1.5 V	1.4		1.4		
		$I_{OH} = -50 \ \mu A$	3 V	2.9		2.9		
V	\/ \/ or\/		4.5 V	4.4		4.4		V
V <sub>OH</sub>	$V_I = V_{IH}$ or $V_{IL}$	I <sub>OH</sub> = -4mA	3 V	2.58		2.4		V
		$I_{OH} = -24 \text{ mA}$	4.5 V	3.94		3.7		
		$I_{OH} = -50 \text{ mA}^{(1)}$	5.5 V			3.85		
			1.5 V		0.1		0.1	
		$I_{OL} = 50 \mu A$	3 V		0.1		0.1	
			4.5 V		0.1		0.1	V
V <sub>OL</sub>	$V_I = V_{IH}$ or $V_{IL}$	I <sub>OL</sub> = 12 mA	3 V		0.36		0.5	V
		I <sub>OL</sub> = 24 mA	4.5 V		0.36		0.525	
		$I_{OL} = 50 \text{ mA}^{(1)}$	5.5 V				1.65	
I <sub>I</sub>	$V_I = V_{CC}$ or GND	,	5.5 V		±0.1		±1	μА
I <sub>CC</sub>	$V_I = V_{CC}$ or GND,	I <sub>O</sub> = 0	5.5 V		4		80	μΑ
C <sub>I</sub>					10		10	pF

<sup>(1)</sup> Test one output at a time, not exceeding 1-second duration. Measurement is made by forcing indicated current and measuring voltage to minimize power dissipation. Test verifies a minimum 50-Ω transmission-line drive capability at 85°C and 75-Ω transmission-line drive capability at 125°C.



### **SWITCHING CHARACTERISTICS**

over recommended operating free-air temperature range,  $V_{CC} = 1.5 \text{ V}$ ,  $C_L = 50 \text{ pF}$  (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	−55°C TO 125°C	UNIT
	(INFOT)	(001701)	MIN MA	<b>(</b>
t <sub>PLH</sub>	A or B	V	14	
t <sub>PHL</sub>	A or B	T T	14	ns 4

### **SWITCHING CHARACTERISTICS**

over recommended operating free-air temperature range,  $V_{CC}$  = 3.3 V ± 0.3 V,  $C_L$  = 50 pF (unless otherwise noted) (see Figure 1)

PARAMETER	ARAMETER FROM TO (OUTPUT)		–55°C 125		UNIT
	(INFOT)	(001701)	MIN	MAX	
t <sub>PLH</sub>	A or D	V	4	16.1	20
t <sub>PHL</sub>	A or B	Ť	4	16.1	ns

### **SWITCHING CHARACTERISTICS**

over recommended operating free-air temperature range,  $V_{CC}$  = 5 V ± 0.5 V,  $C_L$  = 50 pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	–55°C 125		UNIT
	(INFOT)	(001701)	MIN	MAX	
t <sub>PLH</sub>	A or B	V	2.9	11.5	20
t <sub>PHL</sub>	AOIB	ı	2.9	11.5	ns

# **OPERATING CHARACTERISTICS**

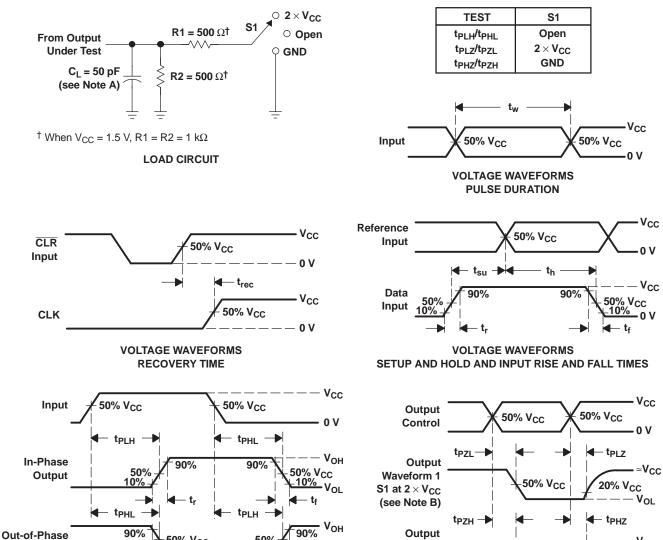
 $V_{CC} = 5 \text{ V}, T_A = 25^{\circ}\text{C}$ 

	PARAMETER			
$C_{pd}$	Power dissipation capacitance	55	pF	

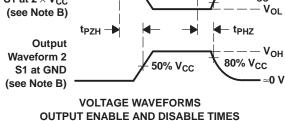
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#### PARAMETER MEASUREMENT INFORMATION



**VOLTAGE WAVEFORMS** PROPAGATION DELAY AND OUTPUT TRANSITION TIMES



NOTES: A. C<sub>L</sub> includes probe and test-fixture capacitance.

Output

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz,  $Z_O = 50 \Omega$ ,  $t_r = 3 \text{ ns}$ ,  $t_f = 3 \text{ ns}$ . Phase relationships between waveforms are arbitrary.
- D. For clock inputs,  $f_{\text{max}}$  is measured with the input duty cycle at 50%.
- E. The outputs are measured one at a time with one input transition per measurement.
- F. t<sub>PLH</sub> and t<sub>PHL</sub> are the same as t<sub>pd</sub>.
- G. t<sub>PZL</sub> and t<sub>PZH</sub> are the same as t<sub>en</sub>.
- H.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .

Figure 1. Load Circuit and Voltage Waveforms

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#### PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing		Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
5962-8761203VCA	ACTIVE	CDIP	J	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-8761203VC A SNV54AC02J	Samples
5962-8761203VDA	ACTIVE	CFP	W	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-8761203VD A SNV54AC02W	Samples

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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# **PACKAGE OPTION ADDENDUM**

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

#### OTHER QUALIFIED VERSIONS OF SN54AC02-SP:

● Catalog : SN54AC02-DIE

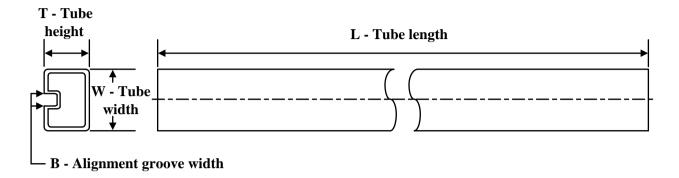
NOTE: Qualified Version Definitions:

• Catalog - TI's standard catalog product

# **PACKAGE MATERIALS INFORMATION**

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# **TUBE**



### \*All dimensions are nominal

Device Package Name		Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)	
5962-8761203VDA	W	CFP	14	25	506.98	26.16	6220	NA	

# W (R-GDFP-F14)

# CERAMIC DUAL FLATPACK



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only.
- E. Falls within MIL STD 1835 GDFP1-F14



CERAMIC DUAL IN LINE PACKAGE



Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.

4040083-5/G





CERAMIC DUAL IN LINE PACKAGE



#### NOTES:

- 1. All controlling linear dimensions are in inches. Dimensions in brackets are in millimeters. Any dimension in brackets or parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This package is hermitically sealed with a ceramic lid using glass frit.
- His package is remitted by sealed with a ceramic its using glass mit.
  Index point is provided on cap for terminal identification only and on press ceramic glass frit seal only.
  Falls within MIL-STD-1835 and GDIP1-T14.



CERAMIC DUAL IN LINE PACKAGE



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